



March 1997

## **CMOS Octal Inverting Bus Transceiver**

## Features

•	Full Eight Bit Bi-Directional Bus Interface
•	Industry Standard 8287 Compatible Pinout
•	High Drive Capability         20mA           - B Side I <sub>OL</sub> 12mA
•	Three-State Inverting Outputs
•	Propagation Delay 35ns Max.
•	Gated Inputs - Reduce Operating Power - Eliminate the Need for Pull-Up Resistors
•	Single 5V Power Supply
•	Low Power Operation ICCSB = $10\mu A$
•	Operating Temperature Range - C82C87H0°C to +70°C

- I82C87H.....-40°C to +85°C - M82C87H....-55°C to +125°C

## Description

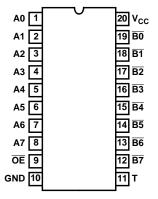
The Intersil 82C87H is a high performance CMOS Octal Transceiver manufactured using a self-aligned silicon gate CMOS process (Scaled SAJI IV). The 82C87H provides a full eight-bit bi-directional bus interface in a 20 pin package. The Transmit (T) control determines the data direction. The active low output enable  $(\overline{\text{OE}})$  permits simple interface to the 80C86, 80C88 and other microprocessors. The 82C87H has gated inputs, eliminating the need for pull-up/pull-down resistors and reducing overall system operating power dissipation. The 82C87H provides inverted data at the outputs.

## **Ordering Information**

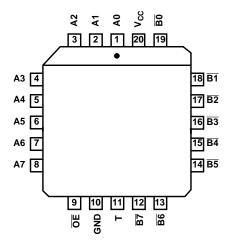
PART NUI	MBERS	PACK-	TEMP.	PKG.	
5MHz	8MHz	AGE	RANGE	NO.	
CP82C87H-5	CP82C87H	20 Ld	0°C to +70°C	E20.3	
IP82C87H-5	IP82C87H	PDIP	-40°C to +85°C	E20.3	
CS82C87H-5	CS82C87H	20 Ld	0°C to +70°C	N20.35	
IS82C87H-5	IS82C87H	PLCC	-40°C to +85°C	N20.35	
CD82C87H-5	CD82C87H	20 Ld CERDIP	0°C to +70°C	F20.3	
ID82C87H-5	ID82C87H		-40°C to +85°C	F20.3	
MD82C87H-5/B	-		-55°C to +125°C	F20.3	
5962- 8757702RA	-	SMD#		F20.3	
MR82C87H-5/B	-	20 Pad CLCC	-55°C to +125°C	J20.A	
5962- 87577022A	-	SMD#		J20.A	

# **蒼훠。"596**2-87577022A"供应商

### 82C87H (PDIP, CERDIP) TOP VIEW



#### 82C87H (PLCC, CLCC) TOP VIEW



### TRUTH TABLE

Т	ŌĒ	Α	В
Х	Н	Hi-Z	Hi-Z
Н	L	I	0
L	L	0	I

= Logic One

L = Logic Zero

I = Input Mode

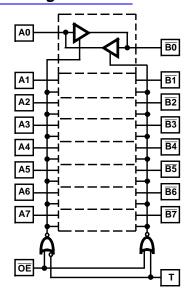
O = Output Mode

X = Don't Care Hi-Z = High Impedance

## PIN NAMES

PIN	DESCRIPTION
A <sub>0</sub> -A <sub>7</sub>	Local Bus Data I/O Pins
B <sub>0</sub> -B <sub>7</sub>	System Bus Data I/O Pins
Т	Transmit Control Input
ŌĒ	Active Low Output Enable

## 查询ct160a47Diagrann供应商



## **Gated Inputs**

During normal system operation of a latch, signals on the bus at the device inputs will become high impedance or make transitions unrelated to the operation of the latch. These unrelated input transitions switch the input circuitry and typically cause an increase in power dissipation in CMOS devices by creating a low resistance path between  $V_{CC}$  and GND when the signal is at or near the input switching threshold. Additionally, if the driving signal becomes high impedance ("float" condition), it could create an indeterminate logic state at the inputs and cause a disruption in device operation.

The Intersil 82C8X series of bus drivers eliminates these conditions by turning off data inputs when data is latched (STB = logic zero for the 82C82/83H) and when the device is disabled ( $\overline{OE}$  = logic one for the 82C87H/87H). These gated inputs disconnect the input circuitry from the V<sub>CC</sub> and ground power supply pins by turning off the upper P-Channel and lower N-Channel (See Figures 1 and 2). No current flow from V<sub>CC</sub> to GND occurs during input transitions and invalid logic states from floating inputs are not transmitted. The next stage is held to a valid logic level internal to the device.

D.C. input voltage levels can also cause an increase in ICC if these input levels approach the minimum  $V_{IH}$  or maximum  $V_{IL}$  conditions. This is due to the operation of the input circuitry in its linear operating region (partially conducting state). The 82C8X series gated inputs mean that this condition will occur only during the time the device is in the transparent mode (STB = logic one). ICC remains below the maximum ICC standby specification of  $10\mu A$  during the time inputs are disabled, thereby greatly reducing the average power dissipation of the 82C8X series devices.

## **Decoupling Capacitors**

The transient current required to charge and discharge the 300pF load capacitance specified in the 82C86H/87H data sheet is determined by:

$$I = C_{L}(dv/dt)$$
 (EQ. 4)

Assuming that all outputs change state at the same time and that dv/dt is constant:

$$I = C_L \frac{(VCC \times 80\%)}{tR/tF}$$
 (EQ. 5)

where tR = 20ns,  $V_{CC}$  = 5.0V,  $C_L$  = 300pF on each eight outputs.

$$I = (80 \times 300 \times 10^{-12}) \times (5.0 \text{V} \times 0.8) / (20 \times 10^{-9})$$

$$= 480 \text{mA}$$
(EQ. 6)

This current spike may cause a large negative voltage spike on  $V_{CC}$  which could cause improper operation of the device. To filter out this noise, it is recommended that a  $0.1\mu F$  ceramic disc capacitor be placed between  $V_{CC}$  and GND at each device, with placement being as near to the device as possible.

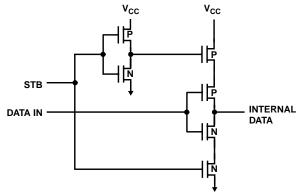


FIGURE 3. 82C82/83H

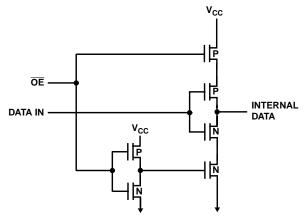


FIGURE 4. 82C86H/87H GATED INPUTS

## 82C87H

## **查詢1696MaX6MUM2Ratil供**应商

Supply Voltage	+8.0V
Input, Output or I/O Voltage	. GND -0.5V to V <sub>CC</sub> +0.5V
ESD Classification	Class 1

### **Operating Conditions**

Operating Voltage Range	+4.5V to +5.5\
Operating Temperature Range	
C82C87H	.0°C to +70°C
I82C87H	
M82C87H	50°C to +125°C

#### **Thermal Information**

$\theta_{JA}$ (°C/W)	$\theta_{JC}$ (°C/W)
70	16
80	20
75	N/A
75	N/A
65 <sup>0</sup>	°C to +150°C
Package	+175°C
ackage	+150°C
0s)	+300°C
	70 80 75 75 75 •••••

#### **Die Characteristics**

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

DC Electrical Specifications  $\begin{array}{ll} V_{CC}=5.0V\pm10\%;\,T_A=0^oC\;to\;+70^oC\;(C82C87H);\\ T_A=-40^oC\;to\;+85^oC\;(I82C87H);\\ T_A=-55^oC\;to\;+125^oC\;(M82C87H) \end{array}$ 

SYMBOL	PARAMETER	MIN	MAX	UNITS	TEST CONDITIONS
V <sub>IH</sub>	Logical One	2.0	-	V	C82C87H, I82C87H
	Input Voltage	2.2	-	V	M82C87H (Note 1)
V <sub>IL</sub>	Logical Zero Input Voltage	-	0.8	V	
V <sub>OH</sub>	Logical One Output Voltage				
	B Outputs	3.0	-	V	I <sub>OH</sub> = -8mA
	A Outputs	3.0	-	V	I <sub>OH</sub> = -4mA
	A or B Outputs	V <sub>CC</sub> -0.4	-	V	I <sub>OH</sub> = -100μA
V <sub>OL</sub>	Logical Zero Output Voltage				
	B Outputs	-	0.45	V	I <sub>OL</sub> = 20mA
	A Outputs	-	0.45	V	I <sub>OL</sub> = 12mA
l <sub>l</sub>	Input Leakage Current	-10.0	10.0	μΑ	V <sub>IN</sub> = GND or V <sub>CC</sub> DIP Pins 9, 11
Ю	Output Leakage Current	-10.0	10.0	μА	VO = GND or $V_{CC}$ , $\overline{OE} \ge V_{CC}$ -0.5V DIP Pins 1 - 8, 12 - 19
ICCSB	Standby Power Supply Current	-	10	μА	$V_{IN} = V_{CC}$ or GND, $V_{CC} = 5.5V$ , Outputs Open
ICCOP	Operating Power Supply Current	-	1	mA/MHz	$T_A = +25^{\circ}C$ , Typical (See Note 2)

#### NOTES:

- 1. V<sub>IH</sub> is measured by applying a pulse of magnitude = V<sub>IH(MIN)</sub> to one data input at a time and checking the corresponding device output for a valid logical "1" during valid input high time. Control pins (T, OE) are tested separately with all device data input pins at V<sub>CC</sub> -0.4.
- 2. Typical ICCOP = 1mA/MHz of read/ cycle time. (Example: 1.0µs read/write cycle time = 1mA).

### **Capacitance** $T_A = +25^{\circ}C$

SYMBOL	PARAMETER	TYPICAL	UNITS	TEST CONDITIONS	
CIN	Input Capacitance				
	B Inputs	18	pF	Freq = 1MHz, all measurements are referenced to device GND	
	A Inputs	14	pF		

The content of the c

 $_{C}$  = 5.0V  $\pm$  10%;  $T_{A}$  = 0°C to +70°C (C82C87H);

 $T_A = -40^{\circ}C \text{ to } +85^{\circ}C \text{ (182C87H)};$ 

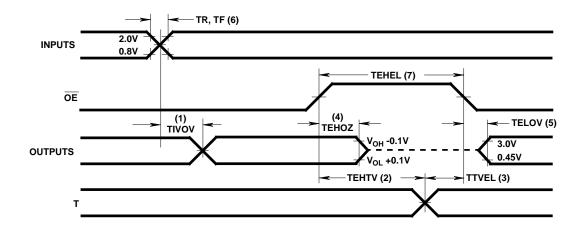
 $T_A = -55^{\circ}C \text{ to } +125^{\circ}C \text{ (M82C87H)}$ 

			NOTE 4			
SYMBOL	PARAMETER	MIN	82C87H MAX	82C87H-5 MAX	UNITS	TEST CONDITIONS
(1) TIVOV	Input to Output Delay					Notes 1, 2
	Inverting	5	30	35	ns	
	Non-Inverting	5	32	35	ns	
(2) TEHTV	Transmit/Receive Hold Time	5	-	-	ns	Notes 1, 2
(3) TTVEL	Transmit/Receive Setup Time	10	-	-	ns	Notes 1, 2
(4) TEHOZ	Output Disable Time	5	30	35	ns	Notes 1, 2
(5) TELOV	Output Enable Time	10	50	65	ns	Notes 1, 2
(6) TR, TF	Input Rise/Fall Times	-	20	20	ns	Notes 1, 2
(7) TEHEL	Minimum Output Enable High Time					Note 3
	82C87H	30	-	-	ns	
	82C87H-5	35	-	-	ns	

#### NOTES:

- 1. All AC parameters tested as per test circuits and definitions in timing waveforms and test load circuits. Input rise and fall times are driven at 1ns/V.
- 2. Input test signals must switch between  $V_{IL}$  0.4V and  $V_{IH}$  +0.4V.
- 3. A system limitation only when changing direction. Not a measured parameter.
- 4. 82C87H is available in commercial and industrial temperature ranges only. 82C87H-5 is available in commercial, industrial and military temperature ranges.

## **Timing Waveform**

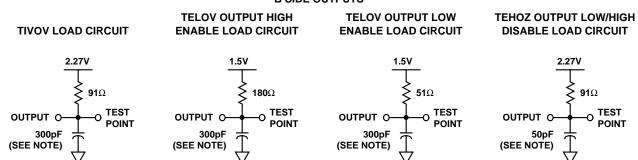


# **秦智"£86ad8でi7で00**44\$"供应商

#### A SIDE OUTPUTS

**TELOV OUTPUT HIGH TELOV OUTPUT LOW TEHOZ OUTPUT LOW/HIGH TIVOV LOAD CIRCUIT ENABLE LOAD CIRCUIT ENABLE LOAD CIRCUIT DISABLE LOAD CIRCUIT** 2.36V 1.5V 1.5V 2.36V  $\mathbf{160}\Omega$  $\mathbf{375}\Omega$  $91\Omega$  $\textbf{160}\Omega$ O TEST o TEST O TEST O TEST POINT **OUTPUT** O OUTPUT O **OUTPUT** O **OUTPUT** O **POINT** POINT **POINT** 100pF 100pF 100pF 50pF (SEE NOTE) (SEE NOTE) (SEE NOTE) (SEE NOTE)

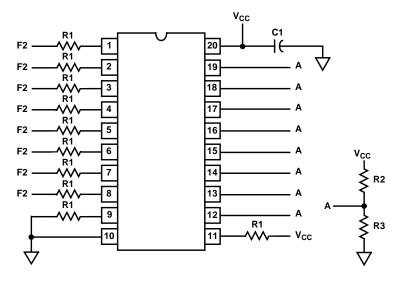
#### **B SIDE OUTPUTS**



NOTE: Includes jig and stray capacitance.

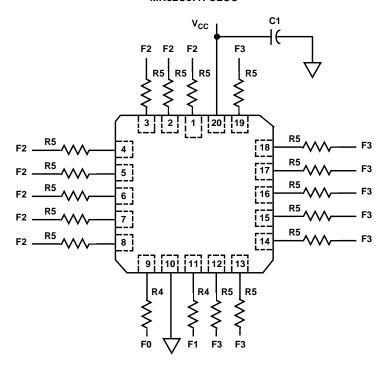
## **Burn-In Circuits**

#### MD82C87H CERDIP



## **查证的5002Ctrcuits**22倍尚供应商

### MR82C87H CLCC



#### NOTES:

- 1.  $V_{CC} = 5.5V \pm 0.5V$ , GND = 0V
- 2.  $V_{IH} = 4.5V \pm 10\%$
- 3.  $V_{IL} = -0.2V$  to 0.4V
- 4. R1 =  $47k\Omega \pm 5\%$
- 5.  $R2 = 2.4k\Omega \pm 5\%$
- 6. R3 = 1.5k $\Omega \pm 5$ %
- 7. R4 =  $1k\Omega \pm 5\%$
- 8.  $R5 = 5k\Omega \pm 5\%$
- 9.  $C1 = 0.01 \mu F$  minimum
- 10.  $F0 = 100kHz \pm 10\%$
- 11. F1 = F0/2, F2 = F1/2, F3 = F2/2

## **查询Chatacteristics**"供应商

**DIE DIMENSIONS:** 

 $138.6 \times 155.5 \times 19 \pm 1 \text{mils}$ 

**METALLIZATION:** 

Type: Si - Al

Thickness: 11kÅ ± 1kÅ

**GLASSIVATION:** 

Type: SiO<sub>2</sub>

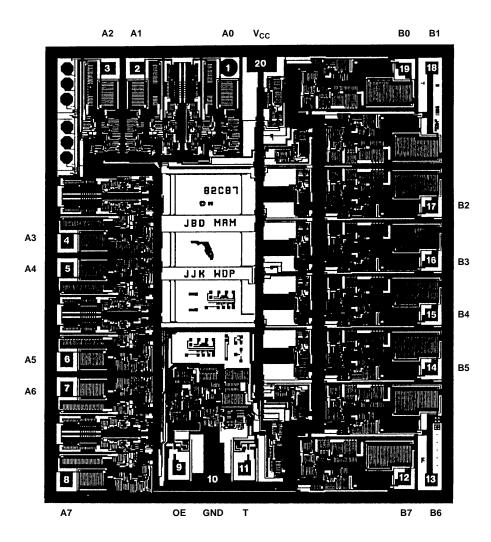
Thickness: 8kÅ ± 1kÅ

**WORST CASE CURRENT DENSITY:** 

 $1.47 \times 10^5 \text{ A/cm}^2$ 

## Metallization Mask Layout

82C87H



All Intersil semiconductor products are manufactured, assembled and tested under ISO9000 quality systems certification.

Intersil products are sold by description only. Intersil Corporation reserves the right to make changes in circuit design and/or specifications at any time without notice. Accordingly, the reader is cautioned to verify that data sheets are current before placing orders. Information furnished by Intersil is believed to be accurate and reliable. However, no responsibility is assumed by Intersil or its subsidiaries for its use; nor for any infringements of patents or other rights of third parties which may result from its use. No license is granted by implication or otherwise under any patent or patent rights of Intersil or its subsidiaries.

For information regarding Intersil Corporation and its products, see web site http://www.intersil.com